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Application/Control No.	Applicant(s)/Patent under Reexamination
10/614,054	KONO ET AL.
Examiner	Art Unit
Gims S. Philippe	2621

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Class	Subclass	Date	Examiner		
375	240.25 240.01 240.28	9/28/2007	GP		
386	68				
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709	202				
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INT	INTERFERENCE SEARCHED		
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